

# Contents

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Mikhail Valentinovich Kovalchuk. On His 65th Birthday	813
Spectral-Selective X-ray Methods for Structure Diagnostics of Ordered Bioorganic Nanosystems on a Liquid Surface <i>N. N. Novikova, M. V. Koval'chuk, N. D. Stepina, O. V. Konovalov, E. A. Yurieva, and E. S. Chukhray</i>	816
Coplanar Three-Beam X-ray Diffraction Study in TeO <sub>2</sub> Single Crystal Using Synchrotron Radiation <i>A. E. Blagov, M. V. Koval'chuk, V. G. Kohn, E. Kh. Mukhamedzhanov, Yu. V. Pisarevsky, and P. A. Prosekov</i>	822
Synchrotron and Neutron-Scattering Methods for Studies of Properties of Condensed Matter: Competition or Complementarity? <i>A. V. Belushkin, D. P. Kozlenko, and A. V. Rogachev</i>	828
The Microstructure of Vertically Coupled Quantum Dots Ensembles by EXAFS Spectroscopy <i>S. B. Erenburg, S. V. Trubina, N. V. Bausk, A. I. Nikiforov, A. V. Dvurechenskii, V. G. Mansurov, K. S. Zhuravlev, and S. G. Nikitenko</i>	856
Study of Physicochemical and Biological Properties of Calcium Phosphate Coatings Prepared by RF Magnetron Sputtering of Silicon-Substituted Hydroxyapatite <i>V. F. Pichugin, M. A. Surmeneva, R. A. Surmenev, I. A. Khlusov, and M. Eppe</i>	863
Simulation of Growth of Silicon Nanowhiskers with Ge–Si Heterojunctions <i>A. G. Nastovjak, I. G. Neizvestny, and N. L. Shwartz</i>	870
Connection of Gibbs Layer Gatherings with Rate of Mass Transfer upon Deposition of Thin Films with Presence of Impurity <i>A. A. Bochkarev and V. I. Polyakova</i>	878
On the Theory of X-Ray Coherent Reflection from a Rough Surface <i>S. V. Salikhov, F. N. Chukhovskii, and A. M. Polyakov</i>	887
Application of a Focused Ion Beam to Prepare Electron Microscopy Samples of Surface Nanostructures <i>R. L. Volkov, N. I. Borgardt, V. N. Kukin, A. S. Prikhod'ko, A. S. Basaev, and Yu. P. Shaman</i>	900
Study of Nanostructures on a Solar Cell Surface Exposed on the <i>Mir</i> Orbital Station <i>N. N. Myagkov, Kh. Kh. Valiev, Yu. G. Yanovskii, Yu. V. Kornev, O. B. Yumashev, and V. N. Rebrikov</i>	905
Radiation Effect on the Electrophysical Properties of Some Oxide Dielectric Materials <i>I. Kh. Abdykadyrova</i>	911
Imaging of a Test Object with a Trapezoidal Profile and Large Side Wall Inclinations in a Scanning Electron Microscope in the Backscattered Electron Mode <i>Yu. A. Novikov</i>	917
Revelation of the Microstructure of Oxide FeAl/Al <sub>2</sub> O <sub>3</sub> Nanocomposite <i>T. Yu. Kiseleva, A. O. Polyakov, A. A. Novakova, and N. N. Sysoev</i>	924
Studies of Structure and Composition of a Pt-Based Basic Electrode for Deposition of PZT Ferroelectric Films on Silicon Substrates <i>V. G. Beshenkov, A. G. Znamenskii, and V. A. Marchenko</i>	930
Electron Probe Microanalysis of HgCdTe Heteroepitaxial Structures with CdTe Buffer Layers <i>S. A. Dvoret'skii, Yu. N. Dolganin, V. V. Karpov, N. N. Mikhailov, N. N. Mikheev, A. A. Mukhanova, A. N. Polyakov, and M. A. Stepovich</i>	934
Optical Properties of 1D Metal Nanogratings <i>I. A. Chernykh, D. A. Mamichev, Yu. V. Grishchenko, V. V. Roddatis, M. L. Zhanaveskin, M. R. Shcherbakov, A. A. Fedyanin, E. G. Novoselova, I. S. Smirnov, and A. N. Marchenkov</i>	941

Study of the Effect of Irradiation with the SEM Electron Beam on Cathodoluminescence and the Induced Current in InGaN/GaN Structures with Multiple Quantum Wells	
<i>P. S. Vergeles, N. M. Shmidt, and E. B. Yakimov</i>	945
Study of Solar Silicon Multicrystals by SEM and EPMA Methods	
<i>L. A. Pavlova, A. I. Nepomnyashchikh, and S. M. Peshcherova</i>	949
SEM Investigation of the Electrical Properties of Silicon Ribbons	
<i>S. K. Brantov, O. V. Feklisova, and E. B. Yakimov</i>	954
Synchrotron Investigations of Electronic and Atomic-Structure Peculiarities for Silicon-Oxide Films' Surface Layers Containing Silicon Nanocrystals	
<i>V. A. Terekhov, S. Yu. Turishchev, K. N. Pankov, I. E. Zanin, E. P. Domashevskaya, D. I. Tetelbaum, A. N. Mikhailov, A. I. Belov, and D. E. Nikolichev</i>	958
Thermostimulated Surface Autosegregation in the Bismuth Ferrite Single Crystals	
<i>Yu. Ya. Tomashpolsky and N. V. Sadovskaya</i>	968
Formation of Surface Gradient Structural-Phase States under Electron-Beam Treatment of Stainless Steel	
<i>V. E. Gromov, S. V. Gorbunov, Yu. F. Ivanov, S. V. Vorobiev, and S. V. Kononov</i>	974
Mutual Electrosurface Transfer and Phase Formation at the MeWO <sub>4</sub>  WO <sub>3</sub> (Me = Ca, Sr, Ba) Interface: Electron Microscopy Data	
<i>A. Ya. Neiman, E. V. Tsipis, V. Yu. Kolosov, N. N. Pestereva, E. A. Elizarova, P. Chapon, and M. Yu. Nekhin</i>	979
Microstructure and Properties of Single-Crystal Rare-Earth Oxide Fibers	
<i>V. V. Voronov, L. D. Iskhakova, V. V. Kashin, S. Ya. Rusanov, and V. B. Tsvetkov</i>	986
Technique for Investigating the Spatial Structure of Thin Films at a Nanolevel	
<i>N. V. Egorov, A. G. Karpov, L. I. Antonova, A. G. Fedorov, V. V. Trofimov, and S. R. Antonov</i>	992
Study of Phase Transformations in the Si <sub>67</sub> Fe <sub>33</sub> Thin-Film System upon Steady-State Annealing	
<i>A. N. Malyshko, A. M. Chaplanov, and E. N. Shcherbakova</i>	996
Effect of Drying Temperature on Sizes and Morphology of Goethite Nanoparticles	
<i>A. A. Novakova, A. R. Savilov, I. I. Puzik, V. V. Levina, N. N. Sysoev, and A. A. Kornilova</i>	1001
Chemical Composition and Surface Morphology of Anodic Alumina Determined by Electron Microscopy and Thermogravimetry	
<i>I. V. Gasenkova, N. I. Mazurenko, and E. V. Ostapenko</i>	1005
Grain Structure and Texture of Rapidly Solidified Foils of Tin and Its Alloys	
<i>O. V. Guskova and V. G. Shepelevich</i>	1011
Application of Fourier Analysis of Scanning Electron Microscopy Images for Studying Variation Features of Reservoir Properties of Carbonate Rocks at Stages of Catagenetic Transformations	
<i>V. A. Kuzmin and N. A. Skibitskaya</i>	1016

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### Errata

Erratum: "Calculation of the Electronic Structure of Metal Island Films" [Journal of Surface Investigation. X-Ray, Synchrotron and Neutron Techniques 4, 672 (2011)]	
<i>E. R. Amanbaev, E. Yu. Zykova, A. A. Klavsyuk, T. N. Polivnikova, A. A. Khaidarov, and A. L. Klavsyuk</i>	1021

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